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Indian Standard



## SPECIFICATION FOR QUARTZ CRYSTAL UNITS USED FOR FREQUENCY CONTROL AND SELECTION

#### PART 2 SERIES AA FOR OSCILLATORS

Section 10 Quartz Crystal Unit Type AA-10

- 0. General This standard shall be read in conjunction with IS: 8271 (Part 1)-1981 'Specification for quartz crystal units used for frequency control and selection: Part 1 General requirements and tests (first revision)'.
- 1. Outline and Dimensions Holder outline shall conform to Type AA ( see Sheet 1A of IS: 4570-1968 Specification for crystal holders).
- 2. Marking See 8 of IS: 8271 (Part 1)-1981.
- 3. Construction and Workmanship See 7 of IS: 8271 (Part 1)-1981.
- 4. Test Schedule and Detail Requirements
- 4.1 General Conditions for Test See 9.2 of IS: 8271 (Part 1)-1981.
- 4.2 Test Schedule The sequence and grouping of type, routine and acceptance tests shall be in accordance with 9.1 of IS: 8271 (Part 1)-1981.
- 4.3 Detail Requirements The detail requirements applicable to this particular type of crystal unit shall be as specified in Table 1.

Adopted 24 August 1984

O November 1984, ISI

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TABLE 1 DETAIL REQUIREMENTS OF QUARTZ CRYSTAL UNIT TYPE AA-10 (C/ause 4.3)

SI No.	Characteristics	Requirements	
(1)	(2)	(3)	
i)	Type of holder	AA (See 1)	
и)	Frequency range	190 to 500 kHz	
iii)	Frequency tolerance:		
	Over operating temperature range	± 20 ppm	
iv)	Frequency stability	± 5 ppm	
v)	Resonance resistance	See Table 2	
۷i)	Mode of oscillation Funda		
vii)	Load capacitance	20.0 $\pm$ 0.5 pF	
viii)	Reference temperature 75°C ± 1°C		
ix)	Temperature range:		
	a) Operating	+70°C to +80°C	
	b) Operable	— 40°C to +70°C	
x)	Test set, calibration values and rated drive level	See Table 3	
(ix	Shock [in accordance with 9.15 (Severity A) of IS: 8271 (Part 1)-1981]:		
	a) Frequency change permitted	± 5 ppm	
	b) Resonance resistance change permitted	$\pm$ 15 percent	
(lix	Vibration [in accordance with 9.16.1 ( Severity A ) of IS: 8271 ( Part 1 )-1981 ]:		
	a) Frequency change permitted	± 5 ppm	
	b) Resonance resistance change permitted	$\pm$ 15 percent	
xiii)	Temperature cycling:		
	a) Frequency change permitted	-± 10ppm	
	b) Resonance resistance change permitted	± 15 percent	
xi <b>∀)</b>	Temperature run:		
	a) Frequency change permitted	$\pm$ 5 ppm	
	b) Resonance resistance change permitted	± 15 percent	
(vx	Bond strength	See Table 4	

#### TABLE 2 RESONANCE RESISTANCE

[ Table 1, Item (v) ]

Frequency Range	Maximum Resonance Resistance ohms		
kHz			
(1)	(2)		
From 190 to 22 <del>5</del>	5 300		
Over 225 to 275	6 000		
Over 275 to 325	6 500		
Over 325 to 375	7.000		
Over 375 to 425	7 500		
Over 425 to 475	8 000		
Over 475 to 500	8 500		

TABLE 3 TEST SET, CALIBRATION VALUES AND RATED DRIVE LEVEL

[ Table 1, Item (x) ]

SI No.	Frequency Range	Calibration Values		Rated	Test Set
NO.	MHz	Resistance ohms	Resistor Voltage Drop V	<b>Drive</b> <b>Level</b> mV	
(1)	(2)	(3)	(4)	(5)	(6)
i)	From 190 to 225	3 700	2·72	7	
ii)	Over 225 to 275	4 200	2 90		
iii)	Over 275 to 325	4 600	3.03	-	
iv)	Over 325 to 375	4 900	3.13	2.0 ± 0.4 }	TS-710/TSM
v)	Over 375 to 425	5 300	3.26	ļ	
vi)	Over 425 to 475	5 600	3·35		
vii)	Over 475 to 500	6 000	3.46		
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#### TABLE 4 BOND STRENGTH

[ Table 1, Item (xv) ]

Frequency Range kHz	Minimum Bond Strength N		
(1)	(2)		
From 190 to 250	7		
Over 250 to 320	5		
Over 320 to 370	4		
Over 370 to 435	3		
Over 435 to 500	2.5		

### EXPLANATORY NOTE

This standard (Part 2/Sec 10) covers the requirements of crystal unit, quartz, style QC-05 of USS 50903 (1971) 'Detail specification for crystal unit, quartz, styles QC-05, QC-06, QC-07 and QC-08', issued by the Directorate of Standardization, Ministry of Defence (India).